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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/057,413	MARTIN ET AL.	
Examiner	Art Unit	
Hai V. Nguyen	2142	

SEARCHED				
Class	Subclass	Date	Examiner	
709	224	6/17/2006	НИ	
709	227	6/17/2006	HN	
			-	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST Search Updated (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB) ( see search history printout report)	6/17/2006	HN
Limited Classified search : 709/224, 227	6/17/2006	HN

